

General Description

- Trench Power LV MOSFET technology
- High density cell design for low R_{DS(ON)}
- High Speed switching

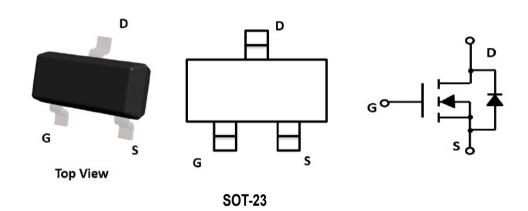
Applications

- Battery protection
- Load switch
- Power management





VDS	30	٧
RDS(on),Typ.@ VGS=10 V	20	mΩ
ID	5.6	Α



Absolute Maximum Ratings (T_A=25 ℃ unless otherwise noted)

Parameter		Symbol	Limit	Unit	
Drain-source Voltage		V_{DS}	30	V	
Gate-source Voltage		V_{GS}	±12	V	
Drain Current	T _A =25℃	1	5.6	А	
Drain Current	T _A =70°C	- I _D	4.5		
Pulsed Drain Current ^A		I _{DM}	23	А	
Total Power Dissipation	T _A =25℃	P₀	1.2	W	
Total Fower Dissipation	T _A =70℃	FD	0.8	W	
Thermal Resistance Junction-to-Ambient ^B		R _{0JA}	104	°C/W	
Junction and Storage Temperature Range		T_J,T_STG	- 55∼+150	$^{\circ}$	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Тур	Max	Units
Static Parameter			'	1		
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V,V _{GS} =0V			1	μA
Gate-Body Leakage Current	I _{GSS1}	V_{GS} = \pm 12 V , V_{DS} =0 V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V_{DS} = V_{GS} , I_D =250 μ A	0.65	0.9	1.5	٧
		V _{GS} =10V, I _D =5.6A		20	25	
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =5A		23	31	mΩ
		V _{GS} =2.5V, I _D =3A		27	45	
Diode Forward Voltage	V _{SD}	I _S =5.6A,V _{GS} =0V			1.2	V
Dynamic Parameters						
Input Capacitance	C _{iss}			630		pF
Output Capacitance	C _{oss}	V_{DS} =15V, V_{GS} =0V,f=1MHZ		55		
Reverse Transfer Capacitance	C _{rss}			71		
Switching Parameters			1	1	1	
Total Gate Charge	Q _g			17.25		
Gate-Source Charge	Q _{gs}	V _{GS} =10V,V _{DS} =15V,I _D =5.6A		2.1		
Gate-Drain Charge	Q _{gd}			2		- nC
Reverse Recovery Chrage	Q _{rr}	L 504 W/W 4004/		1.1		
Reverse Recovery Time	t _{rr}	I _F =5.6A, di/dt=100A/us		13.1		
Turn-on Delay Time	t _{D(on)}			4.4		
Turn-on Rise Time	t _r	V_{GS} =10V, V_{DS} =15V, I_{D} =5.6A		28.2		ns
Turn-off Delay Time	t _{D(off)}	R _{GEN} =3Ω		16.2		
Turn-off fall Time	t _f			26		

A. Pulse Test: Pulse Width \leqslant 300us, Duty cycle \leqslant 2%.

B. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.



Typical Performance Characteristics

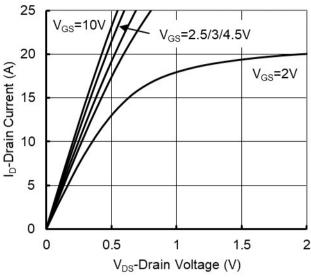


Figure 1. Output Characteristics

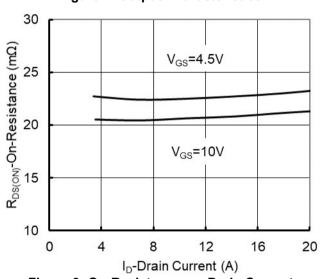


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

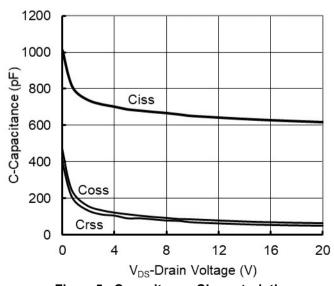


Figure 5. Capacitance Characteristics

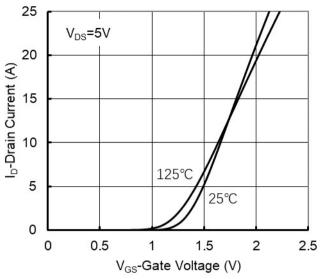


Figure 2. Transfer Characteristics

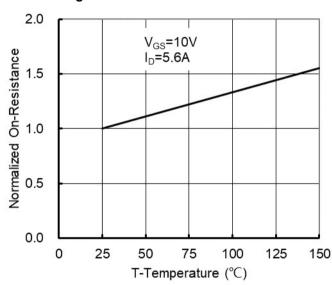


Figure 4: On-Resistance vs. Junction Temperature

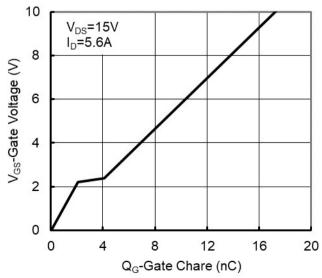


Figure 6. Gate Charge



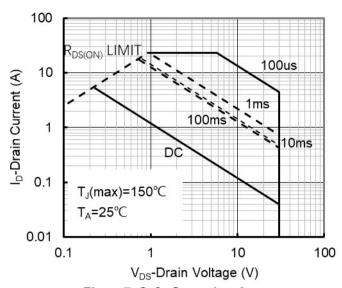


Figure 7. Safe Operation Area

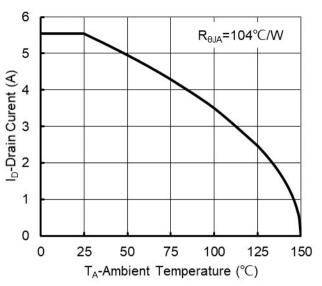


Figure8. Maximum Continuous Drain Current vs Ambient Temperature

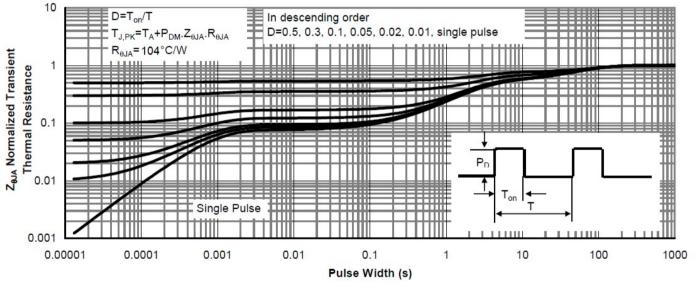
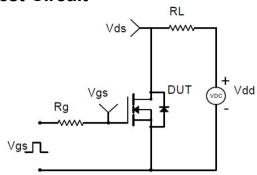
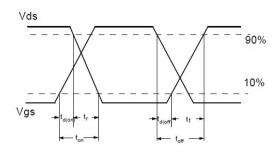


Figure 9. Normalized Maximum Transient Thermal Impedance

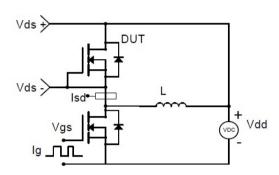


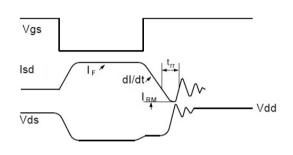
Test Circuit



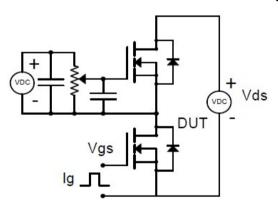


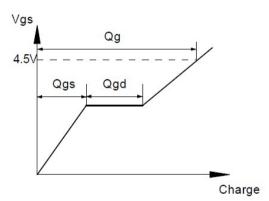
Resistive Switching Test Circuit & Waveforms



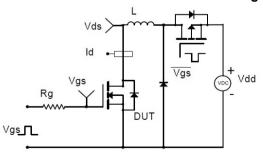


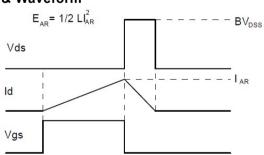
Diode Recovery Test Circuit & Waveforms





Gate Charge Test Circuit & Waveform





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



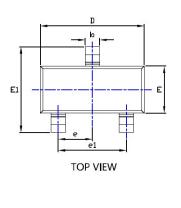
Ordering and Marking Information

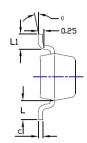
Ordering Device No.	Marking	Package	Packing	Quantity
ASDM3400ZA-R	A09T	SOT-23	Tape&Reel	3000/Reel

SOT-23	PACKAGE	MARKING
		A09T



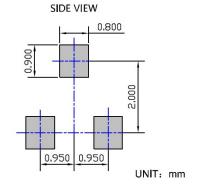
SOT-23 Package information





AZ A

SIDE VIEW



SUGGESTED SOLDER PAD LAYOUT

	DIMENSIONS					
SYMBOL	INCHES			Millimeter		
2 I WRITE	MIN.	NDM,	MAX.	MIN,	NDM.	MAX.
Α	0.035		0,045	0,900		1,150
A1	0,000		0,004	0,000		0,100
A2	0,035	0.038	0.041	0.900 0,975 1.		
b	0,012	0.016	0.020	0.300 0.400 0.5		0.500
u	0,004	-	0.008	0.100 0.2		0.200
D	0.110	0.114	0.118	2.800 2.900		3,000
E	0.047	0,051	0,055	1.200 1.300		1,400
E1	0,089	0,094	0.100	2,250 2,400 2,5		2,550
е	0.037TYP			0.950TYP		
e1	0.071	0.075	0.079	1.800	1.900	2.000
L	0.022REF 0.550REF			10		
L1	0.012	0.016	0,200	0,300	0,400	0,500
θ	0, 8, 0,				8*	

NOTE

- 1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS,
- 2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
- 3.THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.

30V N-Channel MOSFET



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